

# UTT150N06-VB Datasheet N-Channel 60 V (D-S) MOSFET

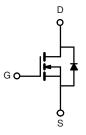
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	60			
$R_{DS(on)} (\Omega)$ at $V_{GS} = 10 V$	0.0016			
$R_{DS(on)}$ ( $\Omega$ ) at $V_{GS}$ = 4.5 V	0.0020			
I <sub>D</sub> (A)	270			
Configuration	Single			

### **FEATURES**

- Trench power MOSFET
- Package with low thermal resistance
- 100 %  $\rm R_g$  and UIS tested







N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_c = 25 \text{ °C}$ , unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	60	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
Continuous Drain Current	T <sub>C</sub> = 25 °C	- I <sub>D</sub> -	270		
	T <sub>C</sub> = 125 °C		120 <sup>a</sup>		
Continuous Source Current (Diode Conduction)		I <sub>S</sub>	120 <sup>a</sup>	А	
Pulsed Drain Current <sup>b</sup>		I <sub>DM</sub>	600		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	75		
Single Pulse Avalanche Energy		E <sub>AS</sub>	281	mJ	
Maximum Power Dissipation <sup>b</sup>	T <sub>C</sub> = 25 °C	P <sub>D</sub>	375	W	
	T <sub>C</sub> = 125 °C	טי	125	٧V	
Operating Junction and Storage Temperature Range	ge	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	C°	

THERMAL RESISTANCE RATINGS					
PARAMETER		SYMBOL	LIMIT	UNIT	
Junction-to-Ambient	PCB Mount <sup>c</sup>	R <sub>thJA</sub>	40	°C/W	
unction-to-Case (Drain)		R <sub>thJC</sub>	0.4	0/10	

#### Notes

a. Package limited.

b. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

c. When mounted on 1" square PCB (FR4 material).



<b>SPECIFICATIONS</b> ( $T_c = 25 \text{ °C}$ , unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$		60	-	-	v
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μΑ	1.5	2.0	2.5	v
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>DS</sub> =	$V_{DS} = 0 V, V_{GS} = \pm 20 V$		-	± 100	nA
Zero Gate Voltage Drain Current		$V_{GS} = 0 V$	V <sub>DS</sub> = 60 V	-	-	1	- μΑ
	I <sub>DSS</sub>	$V_{GS} = 0 V$	$V_{DS} = 60 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$	-	-	50	
		$V_{GS} = 0 V$	$V_{DS} = 60 \text{ V}, \text{ T}_{J} = 175 ^{\circ}\text{C}$	-	-	1.5	mA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{GS} = 10 V$	$V_{DS} \ge 5 V$	120	-	-	А
		$V_{GS} = 10 V$	I <sub>D</sub> = 30 A	-	0.0016	-	Ω
Drain-Source On-State Resistance <sup>a</sup>	Р	$V_{GS} = 10 V$	$I_D = 30 \text{ A},  \text{T}_\text{J} = 125 \ ^\circ\text{C}$	-	0.0031	-	
	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A, T <sub>J</sub> = 175 °C	-	0.0037	-	
		$V_{GS} = 4.5 V$	I <sub>D</sub> = 20 A	-	0.0020	-	
Forward Transconductance b	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 30 A		-	164	-	S
Dynamic <sup>b</sup>	·	·				•	
Input Capacitance	C <sub>iss</sub>		V <sub>DS</sub> = 25 V, f = 1 MHz	-	12 060	15 100	pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V		-	5750	7200	
Reverse Transfer Capacitance	C <sub>rss</sub>	1		-	860	1100	
Total Gate Charge <sup>c</sup>	Qg	V <sub>GS</sub> = 10 V	V <sub>DS</sub> = 30 V, I <sub>D</sub> = 80 A	-	128	200	nC
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>			-	33	-	
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>	1		-	11	-	
Gate Resistance	Rg	f = 1 MHz		0.8	1.68	2.6	Ω
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>	$V_{DD} = 30 \text{ V}, \text{ R}_{\text{L}} = 0.375 \ \Omega$ $\text{I}_{\text{D}} \cong 80 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \ \Omega$		-	20	25	ns
Rise Time <sup>c</sup>	t <sub>r</sub>			-	15	40	
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>			-	65	100	
Fall Time <sup>c</sup>	t <sub>f</sub>			-	12	20	
Source-Drain Diode Ratings and Char	acteristics <sup>b</sup>						
Pulsed Current <sup>a</sup>	I <sub>SM</sub>			-	-	300	А
Forward Voltage	V <sub>SD</sub>	I <sub>F</sub> = 80 A, V <sub>GS</sub> = 0 V		-	0.88	1.5	V

Notes

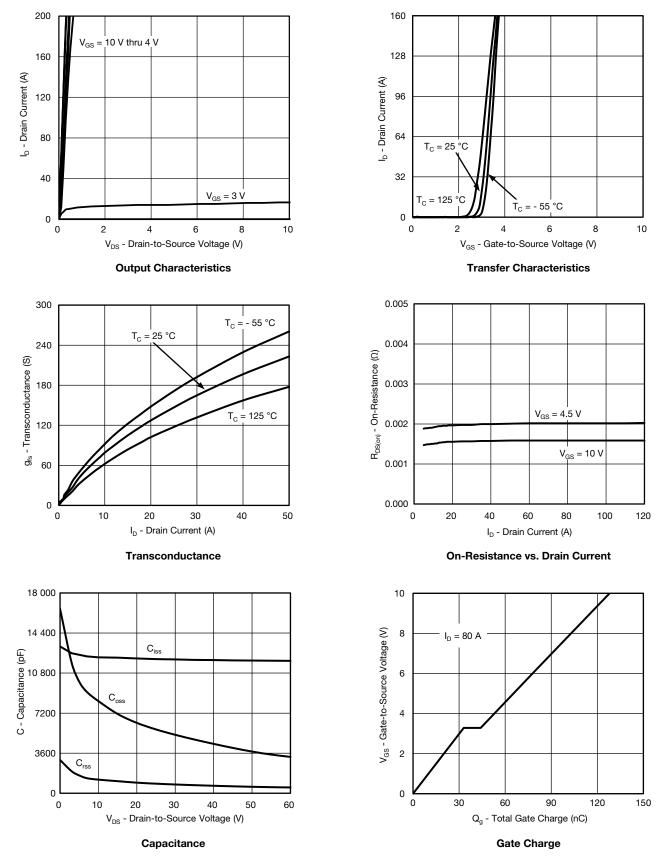
a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

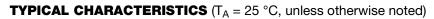


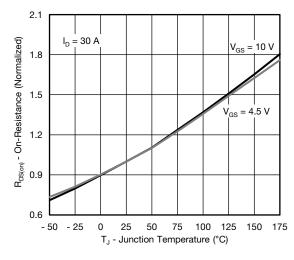
## **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



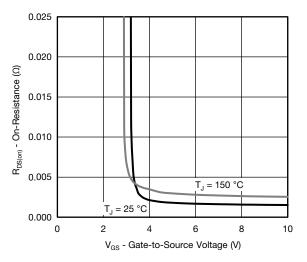
服务热线:400-655-8788



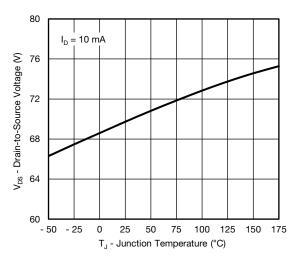




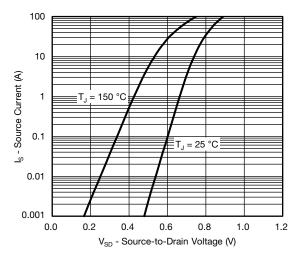
**On-Resistance vs. Junction Temperature** 



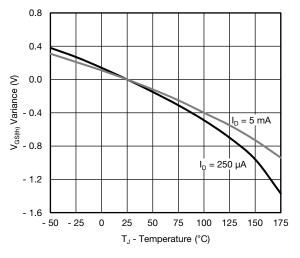
**On-Resistance vs. Gate-to-Source Voltage** 



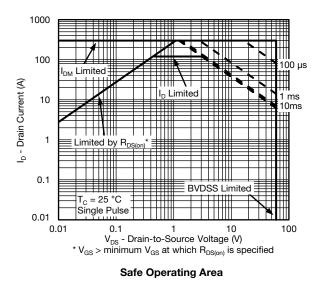
Drain Source Breakdown vs. Junction Temperature



Source Drain Diode Forward Voltage

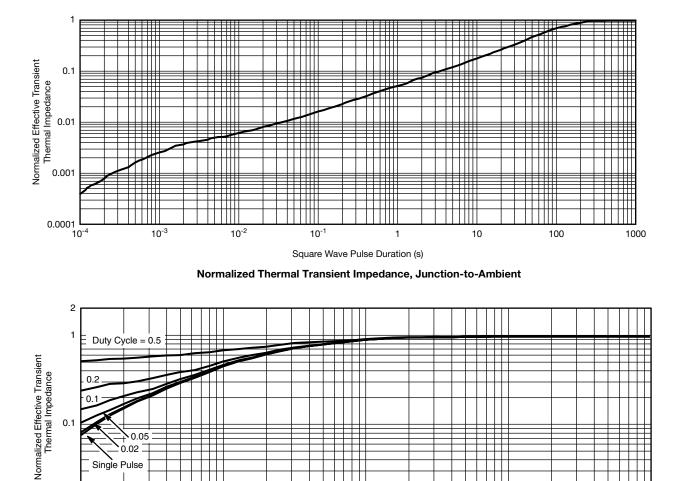


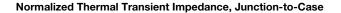
Threshold Voltage





## THERMAL RATINGS (T<sub>A</sub> = 25 °C, unless otherwise noted)





10-1

10-2

Square Wave Pulse Duration (s)

#### Note

0.1

0.01 10-4

The characteristics shown in the two graphs

0.05 0.02 Single Pulse

- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)

10<sup>-3</sup>

- Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

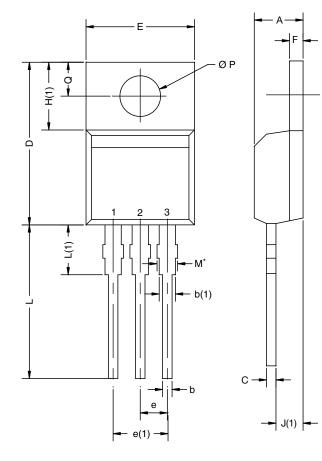
are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.

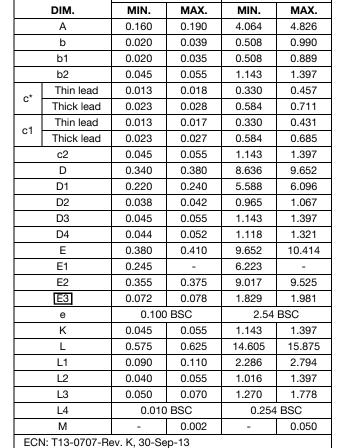
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MILLIMETERS

## **TO-220AB**





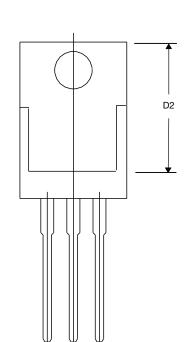
INCHES

DWG: 5843

#### Notes

- 1. Plane B includes maximum features of heat sink tab and plastic.
- 2. No more than 25 % of L1 can fall above seating plane by max. 8 mils.
- 3. Pin-to-pin coplanarity max. 4 mils.
- 4. \*: Thin lead is for SUB, SYB.
  - Thick lead is for SUM, SYM, SQM.
- 5. Use inches as the primary measurement.

This feature is for thick lead.





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